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Docket No.: GR 99 P 1058

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applic. No. : 09/484,781 Confirmation No: 1100
Applicant : Wilfried Daehn
Filed : January 18, 2000
Art Unit : 2819
Examiner : Don Le
Title : Integrated Semiconductor Circuit and Method for Functional
Testing of Pad Cells
Docket No. : GR 99 P 1058
Customer No. : 24131

STATUS LETTER

Commissioner for Patents,
P.O. Box 1450, Alexandria, VA 22313-1450

Sir:

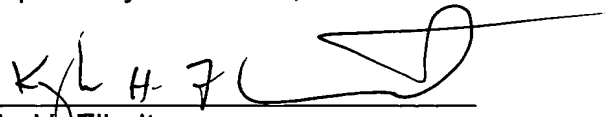
Applicants submitted a status letter on March 17, 2004 to the U.S. Patent Office and received no response.

It is respectfully requested that this **second** Status Letter be returned to:

LERNER AND GREENBERG, P.A.
Post Office Box 2480
Hollywood, FL 33022-2480
Tel: (954) 925-1100
Fax: (954) 925-1101

with an indication as to when an action may be expected.

Respectfully submitted,



Kyle H. Flindt
Reg. No. 42,539

Date: August 23, 2004

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